

Applicati n No.	Applicant(s)	
09/603,310	SPARRELL ET AL.	
Examiner	Art Unit	
Thion D Tran	2665	

SEARCHED				
Class	Subclass	Date	Examiner	
370	277	1/12/2005	тт	
	231	1/12/2005	тт	
	337	1/12/2005	π	
	347	1/12/2005	π	
	314	1/12/2005	тт	
	350	1/12/2005	π	
	468	1/12/2005	TT	
	472	1/12/2005	īΤ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East	1/12/2005	п	
East	1/12/2005	тт	
East	1/12/2005	π	